

**Search Notes**

Application/Control No.

09/983,041

Examiner

Hai V. Nguyen

Applicant(s)/Patent under  
Reexamination

SHIBUYA, ATSUSHI

Art Unit

2142

**SEARCHED**

Class	Subclass	Date	Examiner
ABOVE	UPDATED	1/30/2007	HN
345	1.1, 1.2	1/30/2007	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search Updated (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (see search history printout report)	1/30/2007	HN
Limited classified search: 345/1.1, 1.2 (see search history printout report)	1/30/2007	HN